

# **SPECIFICATION SHEET**

# SILICON CARBIDE (SiC) MOSFET WAFER NC1M SERIES

SPECIFICATION SHEET NO.	S0115- NC1M120C12WD	S0115- NC1M120C12WDCU			
ORIGINAL MFG/PART NO.	NovuSem/NC1M120C12\	NovuSem/NC1M120C12WD			
NEXTGEN PART CODE	NC1M120C12WDCU	Indicate This Code For RFQ/Order			
DATE	Jan. 15, 2025				
REVISION	A1	Updated With Most Recent Data			
DESCRIPTION AND	Silicon Carbide (SiC) MOS	FET, Wafer, NC1M Series,			
MAIN PARAMETRICS	Topside Metallization NiPdAu (4μm)  Drain-Source Voltage (VDS): 1200V, Industrial Grade  Continuous Drain Current (ID) @25°C: 214A  Drain-Source On-State Resistance RDS (ON): 12mΩ  Operating Temperature: -55°C ~ 175°C (TJ)  Package in Wafer Case, REACH/RoHS/RoHS III Compliant				
CUSTOMER					
CUSTOMER PART NUMBER					
CROSS REF. PART NUMBER					
МЕМО					

# **VENDOR APPROVE**

Issued/Checked/Approved



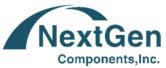




Effective Date: Jan. 15, 2025

CI.	IC.	ΓΟΙ	٨л	CD	) A	ח	ומ	D١	n	١,	Е
u	JS	יטו	V	Er	\ <i>P</i>	۱r	П	'n	U	v	E

Date:



# SILICON CARBIDE (SIC) MOSFET WAFER NCTIVI SERIES

#### **DESCRIPTION**

Silicon Carbide (SiC) MOSFET is produced to spec in accordance by NovuSem with industrial standards. The cost-effective NC1M series products drastically lower both static and dynamic losses. In higher frequency applications, our products can shrink system components such as inductors, capacitors, filters, and transformers, which can increase the overall power density and reduce the total system cost.



Image shown is a representation only.

Exact specifications should be obtained

from the product dimension.

# **MAIN FEATURE**

- Low Switching Loss
- · 175°C Operating Junction Temperature
- High Blocking Voltage With Low On-resistance
- High Speed Switching With Low Capacitances
- · Fast Intrinsic Diode With Low Reverse Recovery (Q rr)
- REACH/RoHS/RoHS III Compliant

# ROHS

#### **APPLICATION**

- PV Inverters
- Charging Piles
- Energy Storage Systems
- Industrial Power Supply
- · Industrial Motors.

#### **ELECTRICAL CHARACTERISTICS**

- See Page 5 ~Page 7.
- All Parameters are Subject To NextGen Components' Final Confirmation



# **HOW TO ORDER**

• Please Follow Up Part Code Guide And Indicate NextGen Part Code <u>NC1M120C12WDCU</u> For RFQ and Order.

#### **PART CODE GUIDE**



CODE	NAME	KEY SPECIFICATION OPTION
NC1M	Product Series Code	NC1D: Novusem Silicon Carbide (SiC) Schottky Diode Gen 1 Industrial Grade series code NC1M: NovuSem Silicon Carbide (SiC) MOSFET Gen 1 Industrial Grade series code
120	Drain-Source Voltage (VDS )	120: 1200V; 65: 650V
С	Material code	C: SiC; S: Silicon
12	Drain-Source On-State Resistance RDS(ON) Code	12:12mΩ ; 40: 40mΩ; 75: 75mΩ; 80: 80mΩ
W	Case Code	A: TO-220-2L; D: TO-252; F: TO-220F; G: TO-247-3L; H: TO-247-4L; K: TO-247-2L; M: DFN5X6; R: TO-263-7L; S: TO-263; T: TO-220-3L W: Wafer
D	Internal Control Code	Letter A~Z, a~z or digits (0~9); Blank: N/A
С	Package Type	C: Wafer Case; T: Tube; R: Tape & Reel
U	Special/Custom Parameters Code	letter or digits (A~Z, a~z or 1~9) for Special Parametric; Blank: N/A

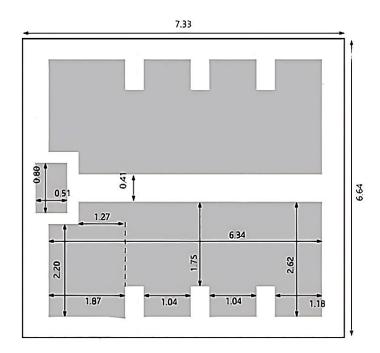


# **MECHANICAL PARAMETERS**

Die Size	7.33mm × 6.64mm (Including Scribe Width)
Thickness	175 ± 15 μm
Source Pad Size	See Pad Layout
Gate Pad Size	0.51mm × 0.80mm
Scribe Line	80 μm

Wafer Size	6 inch
Topside Metallization	NiPdAu (4μm)
Backside Metallization	Ti (0.2μm)- Ni (0.3μm)- Ag (2μm)
Passivation	Polymide

# PAD LAYOUT - Unit: mm, Including Scribe Width



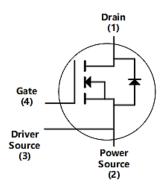


# PART CODE: NC1M120C12WDCU

# SILICON CARBIDE (SiC) MOSFET WAFER NC1M SERIES

#### **INTERNAL CIRCUIT DIAGRAM**

Pin 1 (D): Drain; Pin 2 (S): Power Source; Pin 3 (S): Driver Source; Pin 4 (G): Gate



#### 1200V 12mΩ SiC MOSFET

V DS	I D @ 25°C	R DS (on)	PACKAGE/CASE	Die Size (mm)
1200V	214A	12mΩ	Wafer	7.33 × 6.64

# MAX. RATINGS @Tc=25 °C (Unless Otherwise Specified)

PARAMETER	SYMBOL	TEST CONDITIONS	VALUE	UNIT
Drain-Source Voltage	V DSMax	V GS=0V, I D=100μA	1200	V
Max. Gate-Source Voltage	V GSMax	Static	-8/+22	V
Continuous Drain Current	ΙD	V GS=20V, Tc=25°C	214	А
		V GS=20V, Tc=100°C	151	
Pulsed Drain Current	l D (pulse)	Pulse width tp limited	400	А
		by T jmax		
Operating Junction Temperature Range	TJ		-55 ~	°C
			+175	
Storage Temperature Range	T sтg		-55 ~	°C
			+175	
Maximum Processing Temperature	T Proc		325	°C

Note: \*1. Assume R0JC Thermal Resistance of 0.16°C/W or less \*2. Verified by design



# PART CODE: NC1M120C12WDCU

# SILICON CARBIDE (SiC) MOSFET WAFER NC1M SERIES

# **ELECTRICAL CHARACTERISTICS** @Tc=25 °C (Unless Otherwise Specified)

PARAMETER	SYMBOL	CONDITIONS		VALUE		UNIT
			Min.	Тур.	Max.	
Drain-Source Breakdown Voltage	V (BR) DSS	VGS=0V ID=100μA	1200	-	-	V
Gates Threshold Voltage	V GS(th)	VDS=VGS, ID=40mA	2.0	2.7	3.5	V
		VDS=VGS, ID=40mA, Tj=175°C	-	1.9	-	
Zero Gate Voltage Drain Crurent	loss	VDS=1200V, VGS=0V	-	2	100	μΑ
Gates-Source Leakage Crurent	IGSS	Vgs=20V, Vds=0V	-	10	100	nA
Drain-Source	RDS (ON)	VGS=20V, ID=100A	-	12	20	mΩ
On-State Resistance		VGS=20V, ID=100A, Tj=175°C	-	20	-	
		VGS=18V, ID=100A	_	13	25	
		VGS=18V, ID=100A, Tj=175°C	-	21	-	
Transconductance	gfs	VDS=20V, IDS=100A	-	60	-	S
		V DS=20V, I DS=100A, Tj=175°C	-	52	-	
Gate to Source Charge	Qgs	VDS=800V, VGS=-5V/20V,	-	215	-	nC
Gate to Drain Charge	Qgd	ID=100A	-	179	-	
Total Gate Charge	Qg		-	577	-	
Input Capacitance	Ciss	VGS=0V, VDS=1000V	-	8330	-	pF
Output Capacitance	Coss	f=1MHz VAC=25mV	-	343	-	
Reverse Transfer Capacitance	Crss	VAC-Z3IIIV	-	57	-	
Coss Stored Energy	Eoss		-	217	-	μЈ
Internal Gate Resistance	RG(int)	f=1MHz, VAC=25mV	-	0.8	-	Ω



# REVERSE DIODE CHARACTERISTICS @Tc=25 °C (Unless Otherwise Specified)

PARAMETER	SYMBOL	CONDITIONS	VALUE		UNIT	
			Min.	Тур.	Max.	
Diode Forward Voltage	V SD	V GS =-5V, I SD =50A	-	4.7	-	V
		V GS =-5V, I SD =50A, Tj=175°C	-	3.8	-	V
Reverse Recovery Time	trr	V GS =-5V, I SD =100A	-	46	-	ns
Reverse Recovery Charge	Qrr	V R=800V, di/dt=1597A/μs	-	1	-	μС
Peak Reverse Recovery Current	Irrm		-	37	-	А



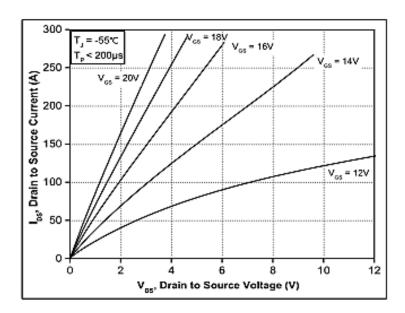


Figure 1. Output Characteristics T<sub>J</sub>=-55°C

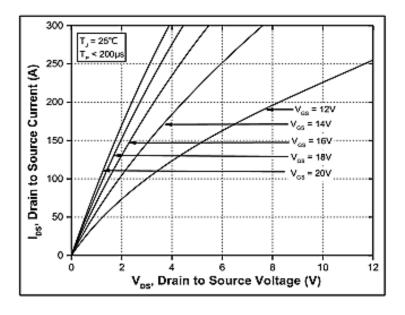


Figure 2. Output Characteristics T<sub>J</sub>=25°C

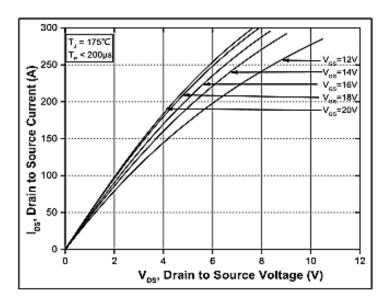


Figure 3. Output Characteristics T<sub>J</sub>=175°C

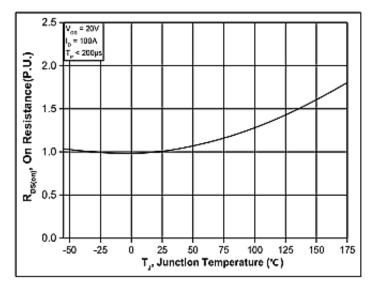


Figure 4. Normalized On-Resistance vs. Temperature

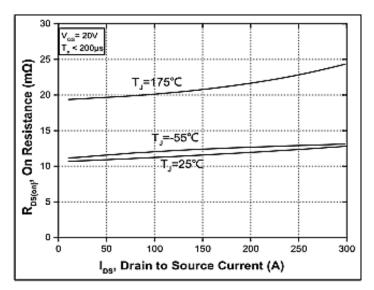


Figure 5. On-Resistance vs. Drain Current For Various Temperatures

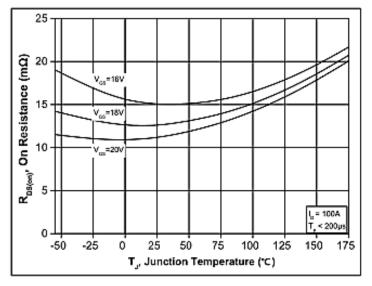


Figure 6. On-Resistance vs. Temperature For Various Gate Voltage

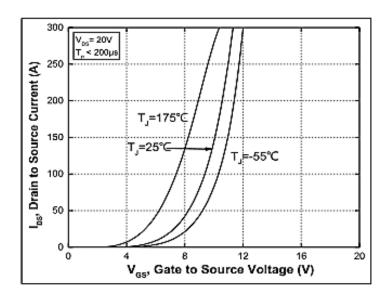


Figure 7. Transfer Characteristic for Various Junction Temperatures

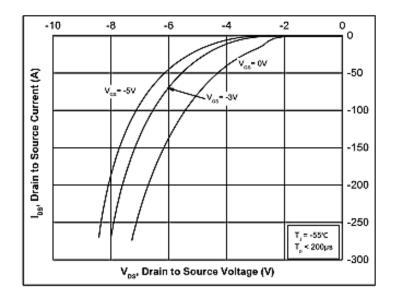


Figure 8. Body Diode Characteristic at -55°C

# **TYPICAL PERFORMANCE** - For Reference Only

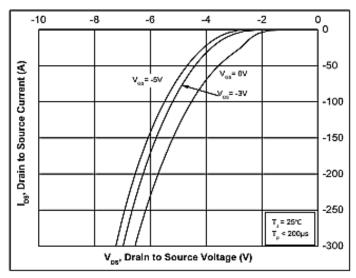


Figure 9. Body Diode Characteristic at 25°C

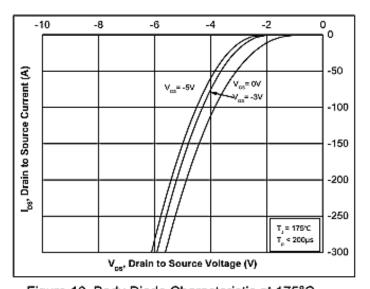


Figure 10. Body Diode Characteristic at 175°C

# **TYPICAL PERFORMANCE** - For Reference Only

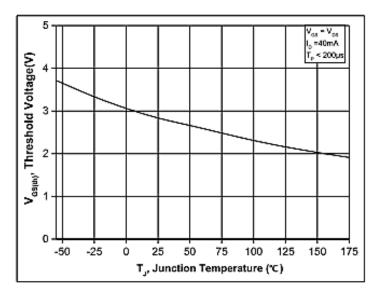


Figure 11. Threshold Voltage vs. Temperature

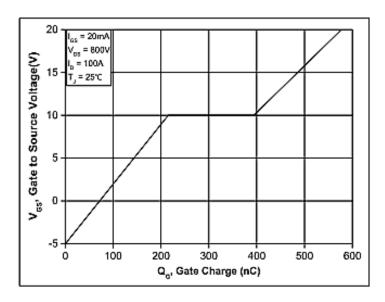


Figure 12. Gate Charge Characteristics

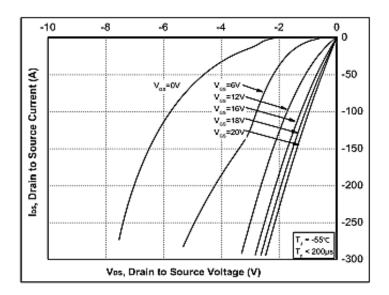


Figure 13. 3rd Quadrant Characteristic at -55°C

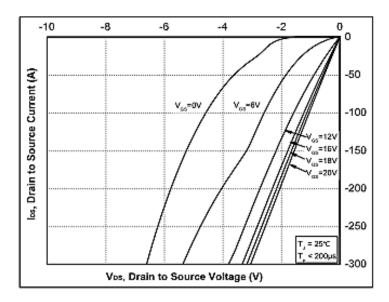


Figure 14. 3rd Quadrant Characteristic at 25°C

1/15/2025 14 www.NextGenComponent.com

# **TYPICAL PERFORMANCE** - For Reference Only

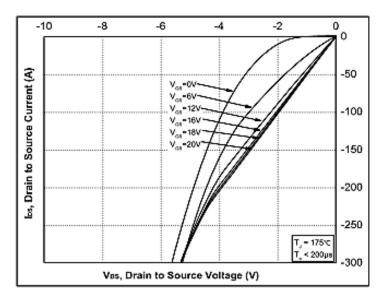


Figure 15. 3rd Quadrant Characteristic at 175°C

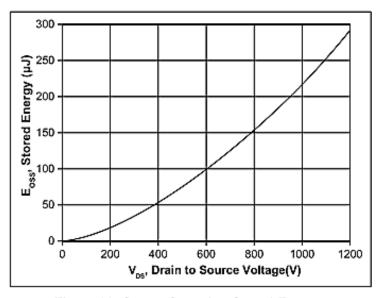


Figure 16. Output Capacitor Stored Energy

# **TYPICAL PERFORMANCE** - For Reference Only

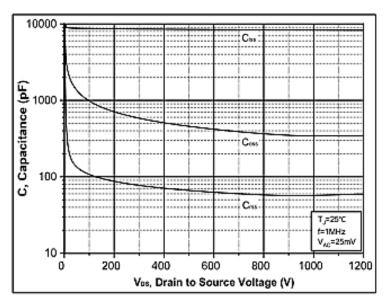


Figure 17. Capacitances vs. Drain-Source Voltage



#### IMPORTANT NOTES AND DISCLAIMER

- ROHS COMPLIANCE: The levels of RoHS restricted materials in this product are below the maximum
  concentration values (also referred to as the threshold limits) permitted for such substances, or are used in an
  exempted application, in accordance with EU RoHS Directive (EU) 2015/863 EC (RoHS3). RoHS Test Report for
  this product can be obtained can be obtained at Download Center.
- 2. REACH COMPLIANCE: REACH substances of high concern (SVHCs) information is available for this product.
  Since the European Chemical Agency (ECHA) has published notice of their intent to frequently revise the SVHC listing for the foreseeable future, REACH Test Report for this product can be obtained at Download Center.
- All Product parametric performance is indicated in the Electrical Characteristics for the listed herein test
  conditions, unless otherwise noted. Product performance may not be indicated by the Electrical
  Characteristics if operated under different conditions.
- 4. NextGen Component, Inc (*NextGen*) reserves the right to make changes to this document and its products and specifications at any time without notice. Customers should obtain and confirm the latest product information and specifications before final design, purchase or use.
- 5. NextGen makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, not does NextGen assume any liability for application assistance or customer product design.
- 6. NextGen does not warrant or accept any liability with products which are purchased or used for any unintended or unauthorized application. No license is granted by implication or otherwise under any intellectual property rights of NextGen.
- NextGen products are not authorized for use as critical components in life support devices or systems without
  express written approval by NextGen.
- 8. NextGen requires that customers first obtain an RMA (Returned Merchandise Authorization) number prior to returning any products. Returns must be made within 30 days of the date of invoice, be in the original packaging, unused and like-new condition. At the time of quoting or purchasing, a product may say that it is Non-Cancelable/ Non-Returnable (NCNR). These products are not returnable and not refundable.